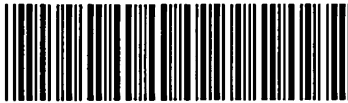


**Search Notes**

Application/Control No.

10/669,809

Examiner

TAN X. DINH

Applicant(s)/Patent under  
Reexamination

KISHIMOTO ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference Search History Printout		12/18/2006	T.D

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see search history printout)	12/18/2006	T.D